

# **OptiMOS**<sup>™</sup>3 Power-Transistor

#### **Features**

- Ideal for high frequency switching and sync. rec.
- Optimized technology for DC/DC converters
- Excellent gate charge x R DS(on) product (FOM)
- N-channel, logic level
- 100% avalanche tested
- Pb-free plating; RoHS compliant
- Qualified according to JEDEC<sup>1)</sup> for target applications
- Halogen-free according to IEC61249-2-21

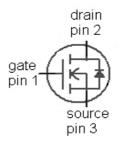
Туре	IPB081N06L3 G	IPP084N06L3 G
	1 3 2 (tab)	123
Package	PG-TO263-3	PG-TO220-3
Marking	081N06L	084N06L

#### **Product Summary**

V <sub>DS</sub>	60	٧
R <sub>DS(on),max (SMD)</sub>	8.1	mΩ
ID	50	А







## **Maximum ratings,** at $T_j$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I <sub>D</sub>	T <sub>C</sub> =25 °C <sup>2)</sup>	50	А
		T <sub>C</sub> =100 °C	50	1
Pulsed drain current <sup>3)</sup>	I <sub>D,pulse</sub>	T <sub>C</sub> =25 °C	200	
Avalanche energy, single pulse <sup>4)</sup>	E <sub>AS</sub>	$I_{\rm D}$ =50 A, $R_{\rm GS}$ =25 Ω	43	mJ
Gate source voltage	$V_{GS}$		±20	V
Power dissipation	$P_{\text{tot}}$	T <sub>C</sub> =25 °C	79	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 175	°C

<sup>1)</sup>J-STD20 and JESD22

 $<sup>^{2)}</sup>$  Current is limited by bondwire; with an  $R_{\rm thJC} = 1.9$  K/W the chip is able to carry 73 A.

<sup>&</sup>lt;sup>3)</sup> See figure 3 for more detailed information

<sup>&</sup>lt;sup>4)</sup> See figure 13 for more detailed information



#### IPB081N06L3 G IPP084N06L3 G

Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	$R_{\mathrm{thJC}}$		-	-	1.9	K/W
Thermal resistance,	$R_{\mathrm{thJA}}$	minimal footprint	-	-	62	
junction - ambient		6 cm² cooling area <sup>5)</sup>	-	-	40	

# **Electrical characteristics,** at $T_{\rm j}$ =25 °C, unless otherwise specified

#### Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA	60	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =34 μA	1.2	1.7	2.2	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> =60 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C	-	0.1	1	μΑ
		V <sub>DS</sub> =60 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C	-	10	100	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	-	1	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V <sub>GS</sub> =10 V, I <sub>D</sub> =50 A	-	7.0	8.4	mΩ
		V <sub>GS</sub> =4.5 V, I <sub>D</sub> =25 A	-	9.7	14.3	
Drain-source on-state resistance	$R_{\mathrm{DS(on)}}$	V <sub>GS</sub> =10 V, I <sub>D</sub> =50 A, (SMD)	-	6.7	8.1	
		V <sub>GS</sub> =4.5 V, I <sub>D</sub> =25 A, (SMD)	-	9.4	14	
Gate resistance	$R_{G}$			0.9	-	Ω
Transconductance	$g_{fs}$	V <sub>DS</sub>  >2 I <sub>D</sub>  R <sub>DS(on)max</sub> , I <sub>D</sub> =50 A	35	69	-	s

 $<sup>^{5)}</sup>$  Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^2$  (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical in still air.



## IPB081N06L3 G IPP084N06L3 G

Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	Ciss		-	3700	4900	рF
Output capacitance	Coss	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, f=1 MHz	-	690	920	1
Reverse transfer capacitance	$C_{rss}$		-	31	-	
Turn-on delay time	$t_{\rm d(on)}$		1	15	-	ns
Rise time	t <sub>r</sub>	V <sub>DD</sub> =30 V, V <sub>GS</sub> =10 V,	1	26	-	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =20 A, $R_{\rm G}$ =1.6 Ω	-	37	-	
Fall time	$t_{\mathrm{f}}$		-	7	-	
Gate Charge Characteristics <sup>6)</sup>						
Gate to source charge	Q <sub>gs</sub>		-	14	-	nC
Gate to drain charge	Q <sub>gd</sub>		-	5	-	_
Switching charge	Q <sub>sw</sub>	V <sub>DD</sub> =30 V, I <sub>D</sub> =50 A, V <sub>GS</sub> =0 to 4.5 V	-	12	-	
Gate charge total	Qg		-	22	29	
Gate plateau voltage	$V_{ m plateau}$		-	3.8	-	٧
Output charge	Q <sub>oss</sub>	V <sub>DD</sub> =30 V, V <sub>GS</sub> =0 V	ı	34	45	nC
Reverse Diode						
Diode continous forward current	Is	т <sub>с</sub> =25 °С	ı	-	50	Α
Diode pulse current	I <sub>S,pulse</sub>		1	-	200	
Diode forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0 V, I <sub>F</sub> =50 A, T <sub>j</sub> =25 °C	1	1.0	1.2	V
Reverse recovery time	t <sub>rr</sub>	V <sub>R</sub> =30 V, I <sub>F</sub> =20A,	1	40	-	ns
Reverse recovery charge	$Q_{rr}$ d $i_F/dt$ =100 A/ $\mu$ s		-	39	-	nC

<sup>&</sup>lt;sup>6)</sup> See figure 16 for gate charge parameter definition

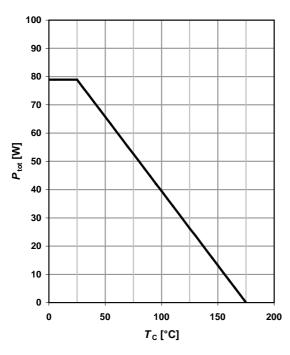


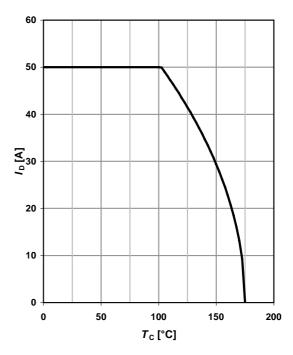
#### 1 Power dissipation

## $P_{\text{tot}}$ =f( $T_{\text{C}}$ )

#### 2 Drain current

$$I_D = f(T_C); V_{GS} \ge 10 \text{ V}$$

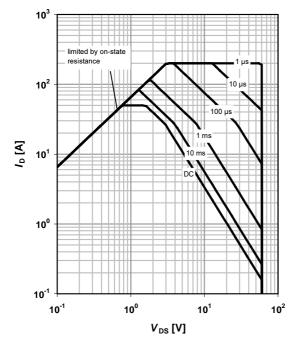




## 3 Safe operating area

$$I_D$$
=f( $V_{DS}$ );  $T_C$ =25 °C;  $D$ =0

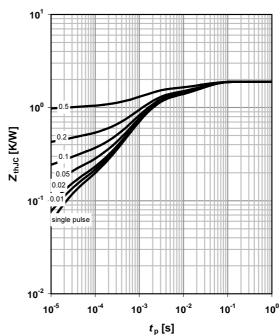
parameter:  $t_p$ 



## 4 Max. transient thermal impedance

$$Z_{\rm thJC}$$
=f( $t_{\rm p}$ )

parameter:  $D = t_p/T$ 

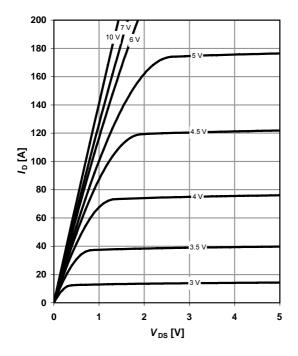




#### 5 Typ. output characteristics

 $I_D=f(V_{DS}); T_j=25 \text{ °C}$ 

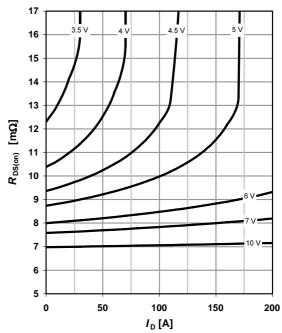
parameter:  $V_{\rm GS}$ 



## 6 Typ. drain-source on resistance

 $R_{DS(on)}$ =f( $I_D$ );  $T_j$ =25 °C

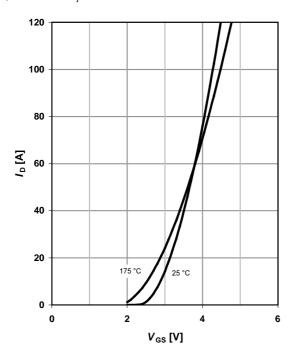
parameter: V<sub>GS</sub>



## 7 Typ. transfer characteristics

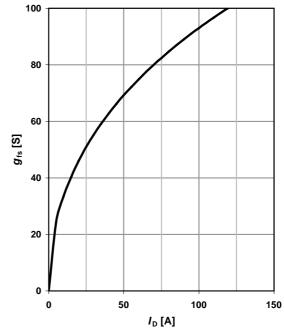
 $I_{D}$ =f( $V_{GS}$ );  $|V_{DS}|$ >2 $|I_{D}|R_{DS(on)max}$ 

parameter:  $T_j$ 



## 8 Typ. forward transconductance

 $g_{fs}$ =f( $I_D$ );  $T_j$ =25 °C





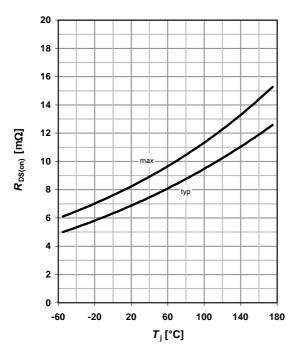
#### 9 Drain-source on-state resistance

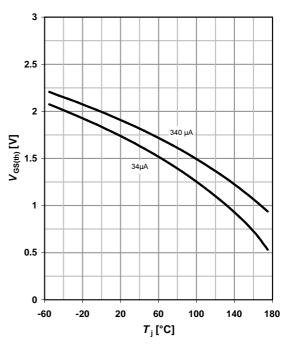
 $R_{DS(on)} = f(T_j); I_D = 50 \text{ A}; V_{GS} = 10 \text{ V}$ 

# 10 Typ. gate threshold voltage

 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$ 

parameter: I<sub>D</sub>





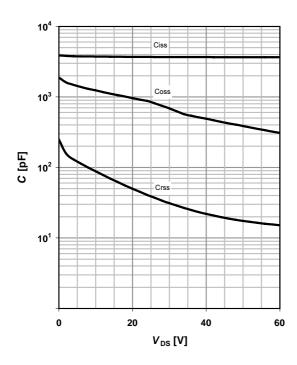
## 11 Typ. capacitances

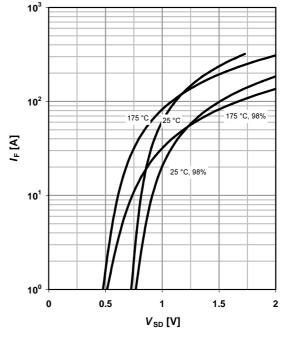
 $C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$ 

#### 12 Forward characteristics of reverse diode

 $I_{F}$ =f( $V_{SD}$ )

parameter:  $T_{\rm j}$ 







#### 13 Avalanche characteristics

 $I_{\mathsf{AS}}$ =f( $t_{\mathsf{AV}}$ );  $R_{\mathsf{GS}}$ =25  $\Omega$ 

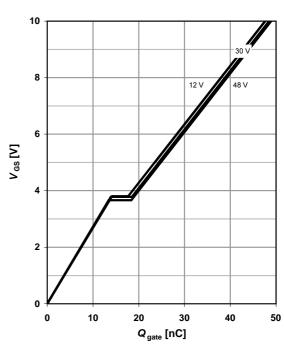
parameter:  $T_{\rm j(start)}$ 

# 100 150°C 100°C 25°C 100°C 25°C 100°C 25°C 100°C 100°

## 14 Typ. gate charge

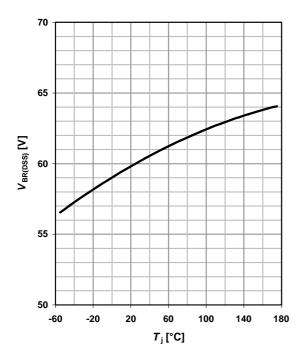
 $V_{\rm GS}$ =f(Q<sub>gate</sub>);  $I_{\rm D}$ =50 A pulsed

parameter:  $V_{\rm DD}$ 

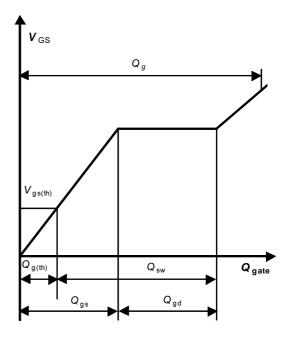


# 15 Drain-source breakdown voltage

 $V_{BR(DSS)}$ = $f(T_j)$ ;  $I_D$ =1 mA

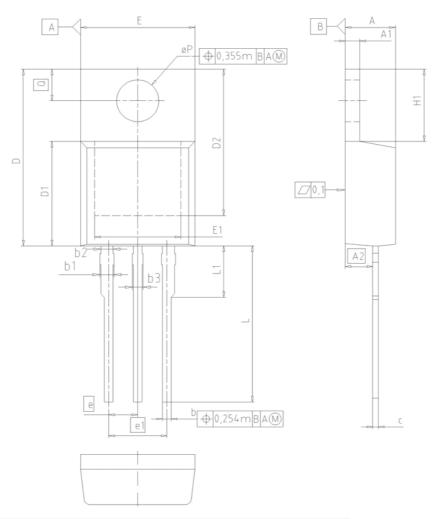


#### 16 Gate charge waveforms





#### PG-TO220-3

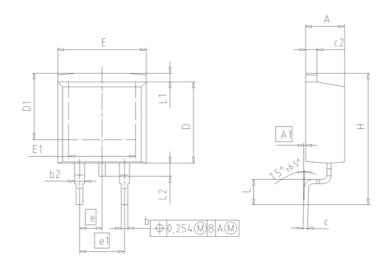


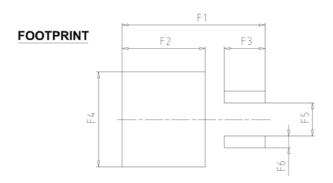
DIM	MILLIN	METERS	INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	4.30	4.57	0.169	0.180	
A1	1.17	1.40	0.046	0.055	
A2	2.15	2.72	0.085	0.107	
b	0.65	0.86	0.026	0.034	
b1	0.95	1.40	0.037	0.055	
b2	0.95	1.15	0.037	0.045	
b3	0.65	1.15	0.026	0.045	
С	0.33	0.60	0.013	0.024	
D	14.81	15.95	0.583	0.628	
D1	8.51	9.45	0.335	0.372	
D2	12.19	13.10	0.480	0.516	
E	9.70	10.36	0.382	0.408	
E1	6.50	8.60	0.256	0.339	
е	2.	54	0.1	00	
e1	5.	08	0.2	200	
N		3	;	3	
H1	5.90	6.90	0.232	0.272	
L	13.00	14.00	0.512	0.551	
L1	-	4.80	-	0.189	
øP	3.60	3.89	0.142	0.153	
Q	2.60	3.00	0.102	0.118	



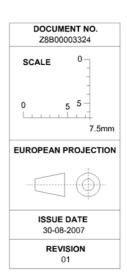


## PG-TO263 (D2-Pak)





DIM	MILLIM	IETERS	INCHES			
DIW	MIN	MAX	MIN	MAX		
Α	4.30	4.57	0.169	0.180		
A1	0.00	0.25	0.000	0.010		
b	0.65	0.85	0.026	0.033		
b2	0.95	1.15	0.037	0.045		
С	0.33	0.65	0.013	0.026		
c2	1.17	1.40	0.046	0.055		
D	8.51	9.45	0.335	0.372		
D1	7.10	7.90	0.280	0.311		
E	9.80	10.31	0.386	0.406		
E1	6.50	8.60	0.256	0.339		
e	2.5	54	0.1	0.100		
e1	5.0	5.08		200		
N		2	2			
Н	14.61	15.88	0.575	0.625		
L	2.29	3.00	0.090	0.118		
L1	0.70	1.60	0.028	0.063		
L2	1.00	1.78	0.039	0.070		
F1	16.05	16.25	0.632	0.640		
F2	9.30	9.50	0.366	0.374		
F3	4.50	4.70	0.177	0.185		
F4	10.70	10.90	0.421	0.429		
F5	3.65	3.85	0.144	0.152		
F6	1.25	1.45	0.049	0.057		





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